IX2127
High-Voltage Power MOSFET & IGBT Driver

Driver Characteristics

Parameter	Rating	Units
V_{OFFSET}	600	V
$I_{O +/-}$ (Source/Sink)	250/500	mA
V_{CSth}	250	mV
t_{ON} / t_{OFF} (Typical)	100	ns

Features

- Floating Channel Designed for Bootstrap Operation up to 600V
- Tolerant to Negative Transient Voltages; dV/dt Immune
- Undervoltage Lockout
- 3.3V, 5V, and 12V Input Logic Compatible
- Open-Drain $\overline{\text{FAULT}}$ Indicator Pin Shows Over-Current Shutdown
- Output in Phase with the Input

Applications

- High-Speed Gate Driver
- Motor Drive Inverter

Description

The IX2127 is a high-voltage, high-speed power MOSFET and IGBT driver. High-voltage level-shift circuitry enables this device to operate up to 600V. Clare's proprietary common-mode design techniques provide stable operation in high dV/dt noise environments.

An on-board comparator can be used to detect an over-current condition in the driven MOSFET or IGBT device, and then shut down drive to that device. An open-drain output, $\overline{\text{FAULT}}$, indicates that an over-current shutdown has occurred.

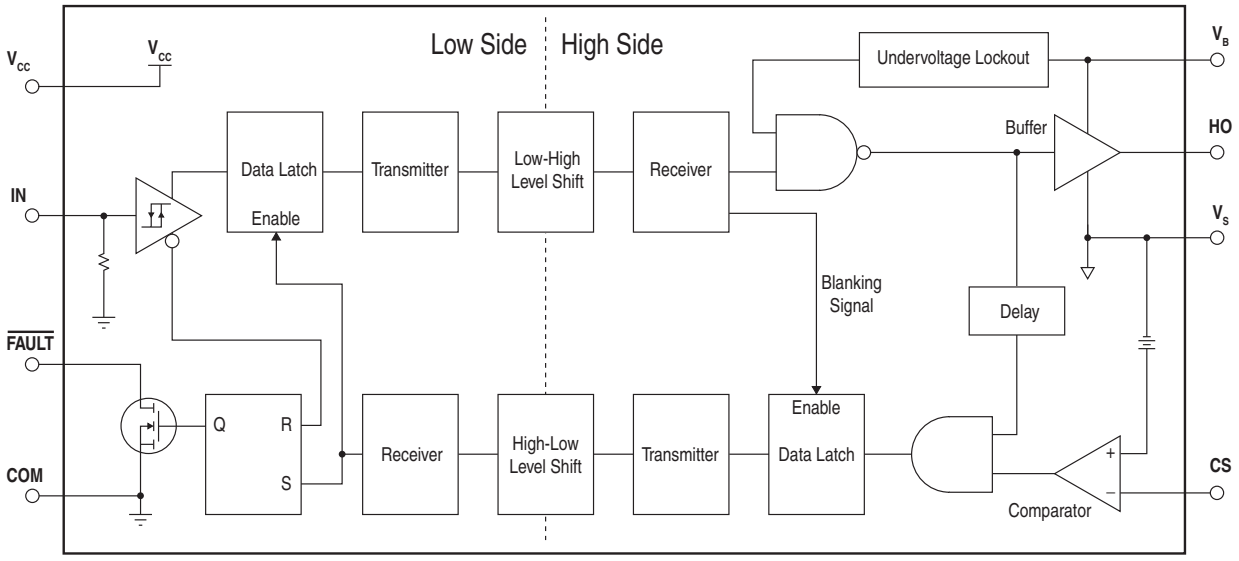
The gate driver output typically can source 250mA and sink 500mA, which is suitable for fluorescent lamp ballast, motor control, SMPS, and other converter drive topologies.

The IX2127 is provided in 8-pin DIP and 8-pin SOIC packages, and is available in Tape & Reel versions. See ordering information below.

Ordering Information

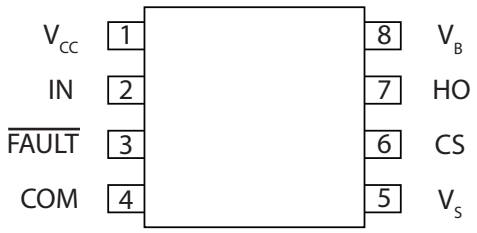
Part	Description
IX2127G	8-Pin DIP (50/Tube)
IX2127N	8-Pin SOIC (100/Tube)
IX2127NTR	8-Pin SOIC (2000/Reel)

IX2127 Block Diagram



1 Specifications

1.1 Package Pinout



1.2 Pin Description

Pin#	Name	Description
1	V_{CC}	Logic Supply Voltage
2	IN	Logic Input
3	$\overline{FAULT}$	Fault Indicator Output
4	COM	Logic Ground
5	V_S	High Side Return
6	CS	Comparator Input, Over-Current Detect
7	HO	High Side Gate Drive Output
8	V_B	High Side Supply Voltage

1.3 Absolute Maximum Ratings

Unless otherwise specified, ratings are provided at T_A=25°C and all bias levels are with respect to COM.

Parameter	Symbol	Minimum	Maximum	Units
Logic Supply Voltage	V_{CC}	-0.3	15	V
High Side Floating Supply Voltage	V_B	-0.3	625	
High Side Floating Offset Voltage	V_S	V_B-12	V_B+0.3	
Logic Input Voltage	V_{IN}	-0.3	V_{CC}+0.3	
High Side Floating Output Voltage	V_{HO}	V_S-0.3	V_B+0.3	
Current Sense Voltage	V_{CS}	V_S-0.3	V_B+0.3	
$\overline{FAULT}$ Output Voltage	V_{FLT}	-0.3	V_{CC}+0.3	
Allowable Offset Supply Voltage Transient	dV_S/dt	-	50	V/ns
Package Power Dissipation				W
8-Lead DIP	P_D	-	1	
8-Lead SOIC		-	0.625	
Junction Temperature	T_J	-	150	°C
Storage Temperature	T_S	-55	150	

Absolute maximum electrical ratings are at 25°C

Absolute maximum ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

1.4 Recommended Operating Conditions

Parameter	Symbol	Minimum	Maximum	Units
Logic Supply	V_{CC}	9	12	V
High Side Floating Supply	V_B	V_S+9	V_S+12	
High Side Offset Voltage	V_S	-5	600	
Logic Input Voltage	V_{IN}	0	V_{CC}	
High Side Floating Output	V_{HO}	V_S	V_B	
Current Sense Signal Voltage	V_{CS}	V_S	V_S+5	
$\overline{\text{FAULT}}$ Output Voltage	V_{FLT}	0	V_{CC}	
Ambient Temperature	T_A	-40	+125	°C

1.5 General Conditions

Typical values are characteristic of the device at 25°C and are the result of engineering evaluations. They are provided for information purposes only and are not part of the manufacturing testing requirements.

Unless otherwise noted, all electrical specifications are listed for T_A=25°C.

1.6 Electrical Characteristics

Unless otherwise specified, the test conditions are: V_{CC}=V_{BS}=12V; V_{CC}, IN, $\overline{\text{FAULT}}$, and Leakage voltages and currents are referenced to COM; V_B, HO, and CS voltages and currents are referenced to V_S .

1.6.1 Power Supply Specifications

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
Quiescent V_{CC} Supply Current	V_{IN}=0V	I_{QCC}	-	280	400	µA
Quiescent V_{BS} Supply Current	V_{IN}=0V	I_{QBS}	-	500	1000	
V_{BS} UVLO Positive-Going Threshold	-	V_{BS_UV+}	6.8	7.7	8.6	V
V_{BS} UVLO Negative-Going Threshold	-	V_{BS_UV-}	6.3	7.2	8.1	
Offset Supply Leakage Current	V_B=V_S=600V	I_{LKG}	-	-	2	µA

1.6.2 Gate Drive and Shutdown Specifications

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
High Level Output Voltage, V_B-V_{HO}	I_{HO}=0A	V_{OH}	-	-	100	mV
Low Level Output Voltage, V_{HO}	I_{HO}=0A	V_{OL}	-	-	100	
Output Short Circuit Pulsed Current	V_{HO}=0V, V_{IN}=5V, PW≤10µs, R_{GATE}=20Ω* (see Figure 1)	I_{HO+}	-200	-250	-	mA
	V_{HO}=12V, V_{IN}=0V, PW≤10µs, R_{GATE}=20Ω* (see Figure 1)	I_{HO-}	420	500	-	
CS Input, Positive-Going Threshold	V_{CC}=9V to 12V	V_{CS_TH+}	180	260	320	mV
"High" CS Bias Current	V_{CS}=3V	I_{CS+}	-	-	1	µA
	V_{CS}=0V	I_{CS-}	-	-	-1	

* R_{GATE} value must be 20Ω or greater.

1.6.3 Logic I/O Specifications

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
Logic "1" Input Voltage	V_{CC}=9V to 12V	V_{IH}	3.0	-	-	V
Logic "0" Input Voltage	V_{CC}=9V to 12V	V_{IL}	-	-	0.8	
Logic "1" Input Bias Current	V_{IN}=5V	I_{IN+}	-	2.6	15	µA
Logic "0" Input Bias Current	V_{IN}=0V	I_{IN-}	-	-	-1	
$\overline{FAULT}$ On-Resistance	-	FLT, R_{ON}	-	72	-	Ω

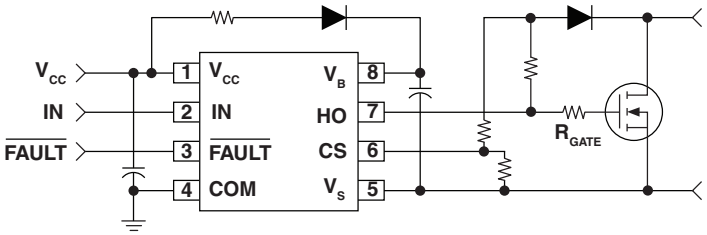
1.6.4 Thermal Specifications

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
Thermal Resistance, Junction to Ambient:	-	$R_{\theta JA}$				°C/W
8-Lead DIP			-	-	125	
8-Lead SOIC			-	-	200	

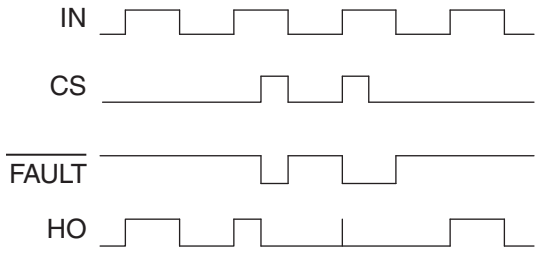
1.7 Timing Characteristics

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
Turn-On Propagation Delay	V_{CC}=V_{BS}=12V, C_L=1nF, T_A=25°C	t_{on}	-	100	200	ns
Turn-Off Propagation Delay		t_{off}	-	73	200	
Turn-On Rise Time		t_r	-	23	130	
Turn-Off Fall Time		t_f	-	20	65	
Start-Up Blanking Delay		t_{blk}	550	766	950	
CS Shutdown Propagation Delay		t_{CS}	-	220	360	
CS to FLT Propagation Delay		t_{FLT}	-	236	510	

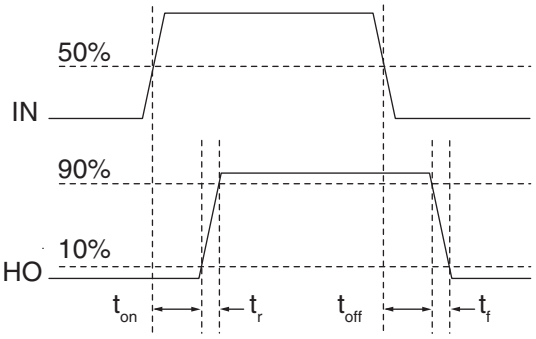
1.7.1 Typical Connection Diagram



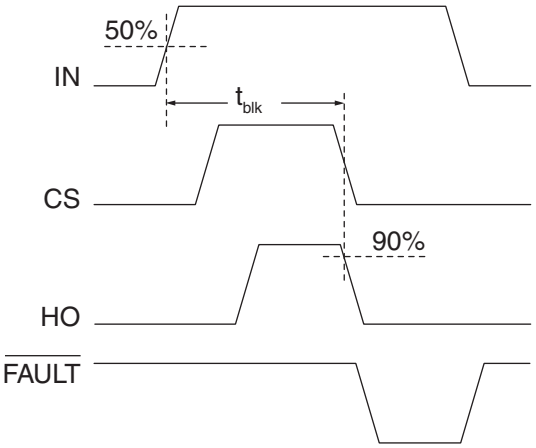
1.7.2 I/O Timing Diagram



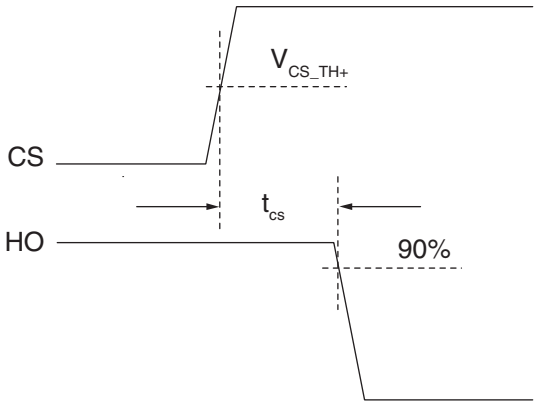
1.7.3 Switching Time Waveforms



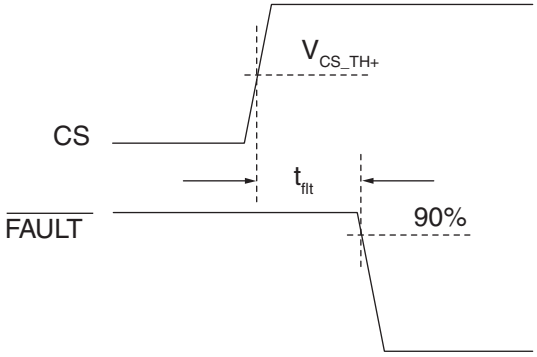
1.7.4 Startup Blanking Time Waveforms



1.7.5 CS Shutdown Waveforms

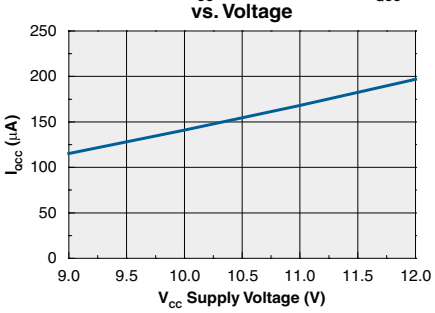


1.7.6 CS to FLT Waveforms

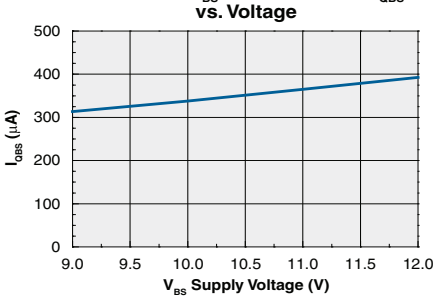


2 Performance Data

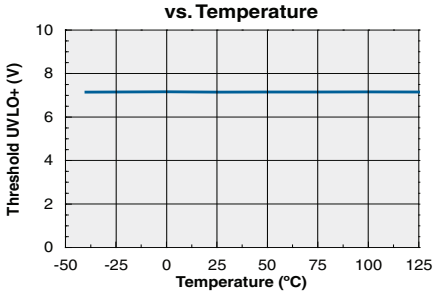
Quiescent V_{CC} Supply Current I_{QCC} vs. Voltage



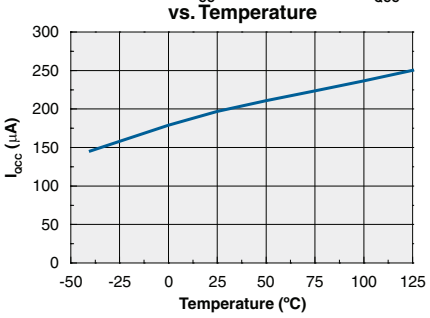
Quiescent V_{BS} Supply Current I_{QBS} vs. Voltage



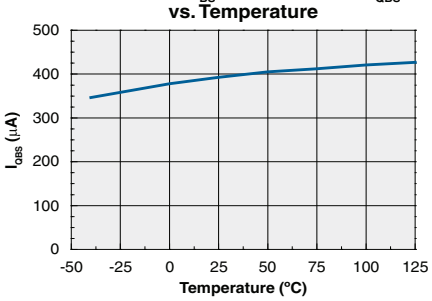
VBS Undervoltage Lockout Positive-Going Threshold UVLO+ vs. Temperature



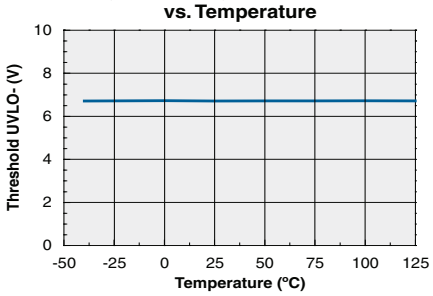
Quiescent V_{CC} Supply Current I_{QCC} vs. Temperature



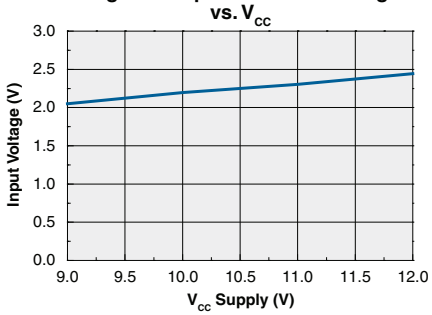
Quiescent V_{BS} Supply Current I_{QBS} vs. Temperature



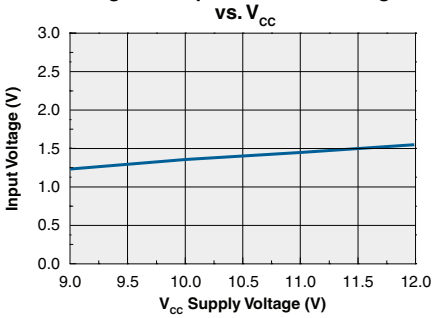
VBS Undervoltage Lockout Negative-Going Threshold UVLO- vs. Temperature



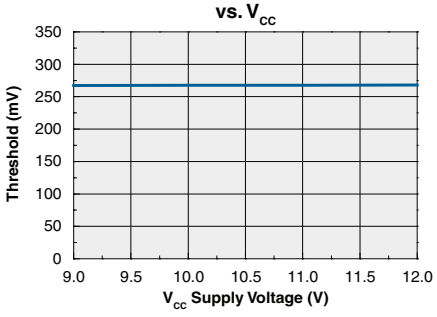
Logic "1" Input Threshold Voltage vs. V_{CC}



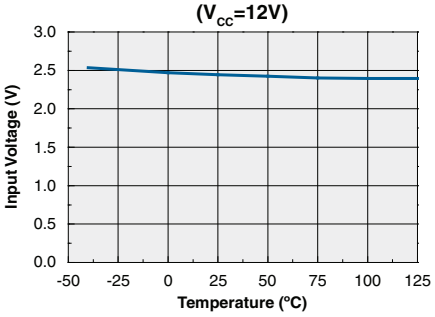
Logic "0" Input Threshold Voltage vs. V_{CC}



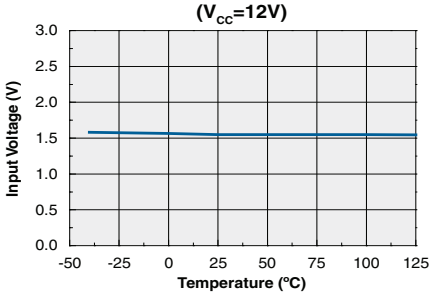
CS Input Positive Going Threshold vs. V_{CC}



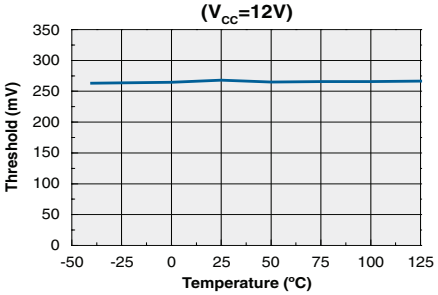
Logic "1" Input Threshold Voltage vs. Temperature (V_{CC}=12V)



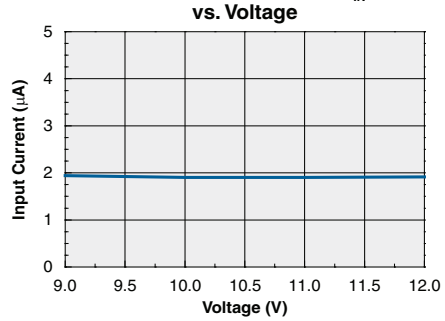
Logic "0" Input Threshold Voltage vs. Temperature (V_{CC}=12V)



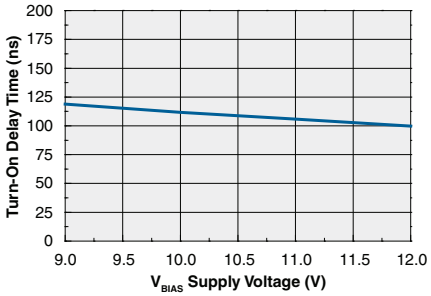
CS Input Positive Going Threshold vs. Temperature (V_{CC}=12V)



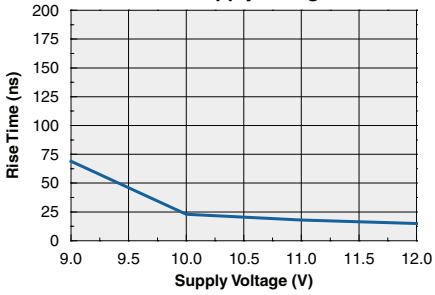
Logic "1" Input Current I_{IN}+ vs. Voltage



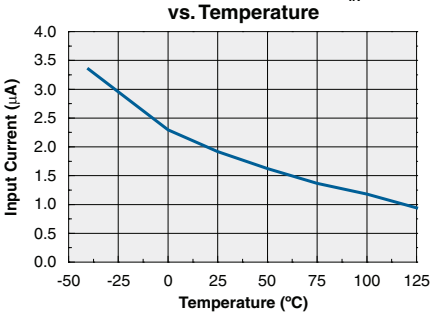
Turn-On Time vs. Supply Voltage



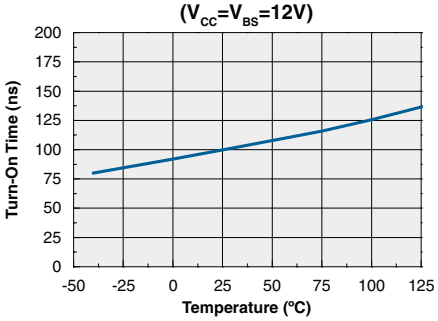
Turn-On Rise Time vs. Supply Voltage



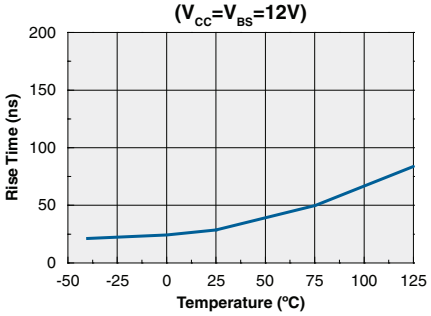
Logic "1" Input Current I_{IN}+ vs. Temperature



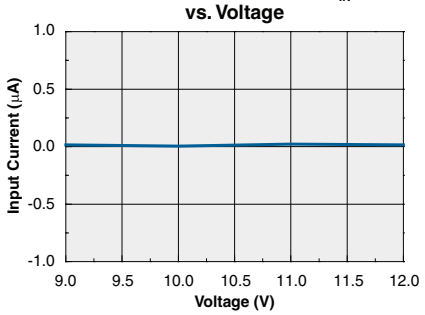
Turn-On Time vs. Temperature (V_{CC}=V_{BS}=12V)



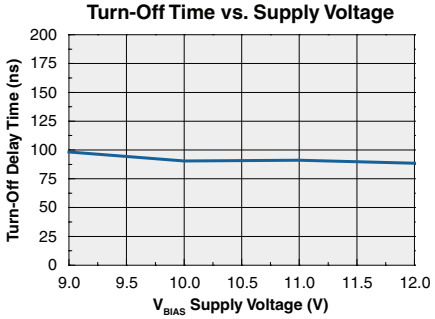
Turn-On Rise Time vs. Temperature (V_{CC}=V_{BS}=12V)



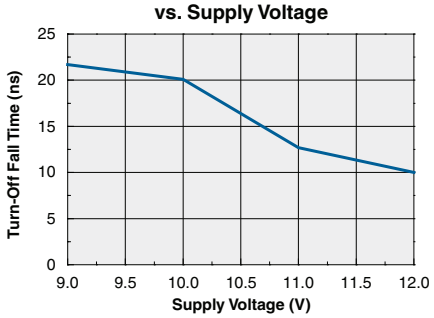
Logic "0" Input Current I_{IN}- vs. Voltage



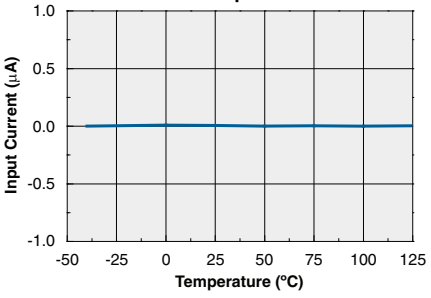
Turn-Off Time vs. Supply Voltage



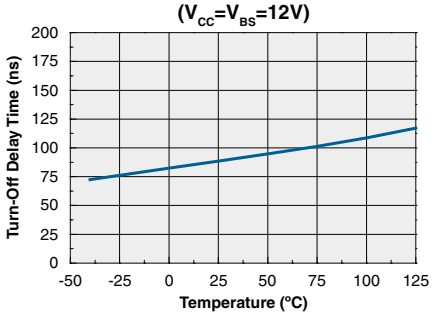
Turn-Off Fall Time vs. Supply Voltage



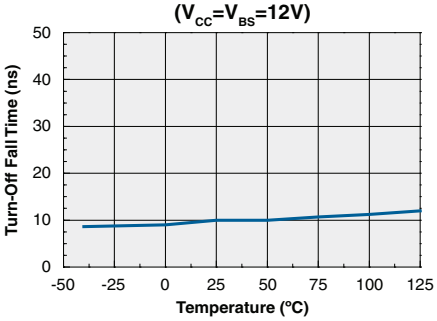
Logic "0" Input Current I_{IN}- vs. Temperature



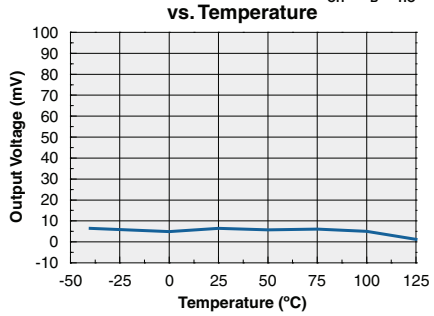
Turn-Off Time vs. Temperature (V_{CC}=V_{BS}=12V)



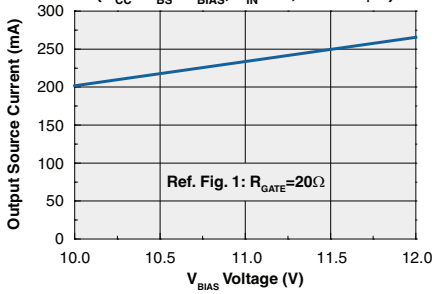
Turn-Off Fall Time vs. Temperature (V_{CC}=V_{BS}=12V)



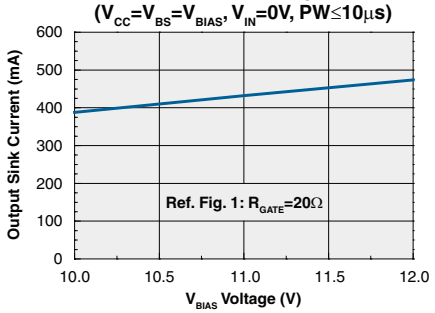
High-Level Output Voltage V_{OH} (V_B-V_{HO}) vs. Temperature



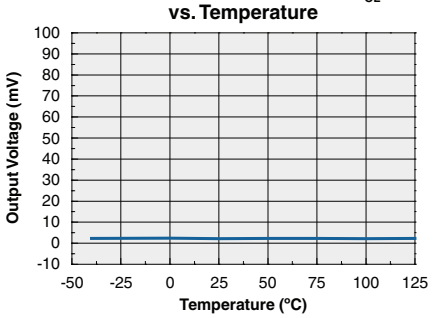
Output Source Current vs. Voltage (V_{CC}=V_{BS}=V_{BIAS}, V_{IN}=5V, PW≤10µs)



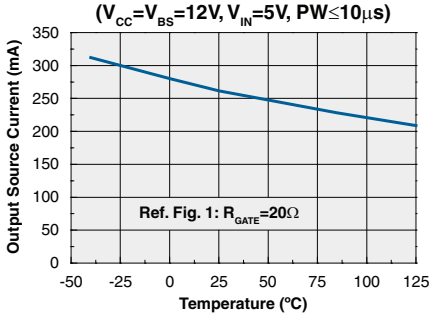
Output Sink Current vs. V Bias Voltage (V_{CC}=V_{BS}=V_{BIAS}, V_{IN}=0V, PW≤10µs)



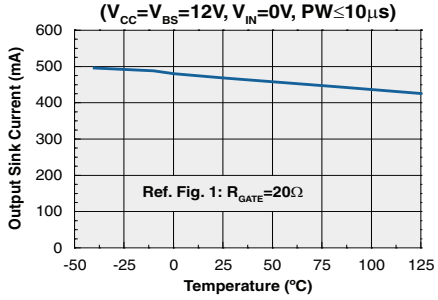
Low-Level Output Voltage V_{OL} vs. Temperature



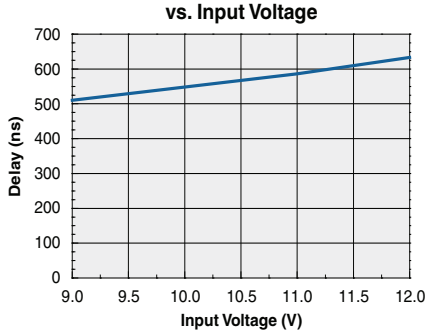
Output Source Current vs. Temperature (V_{CC}=V_{BS}=12V, V_{IN}=5V, PW≤10µs)



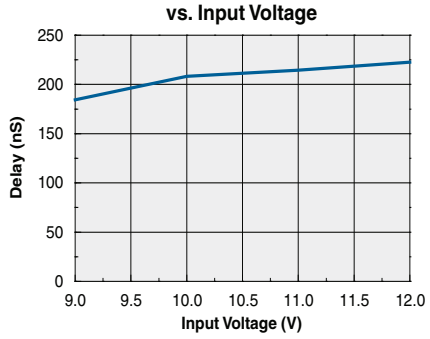
Output Sink Current vs. Temperature (V_{CC}=V_{BS}=12V, V_{IN}=0V, PW≤10µs)



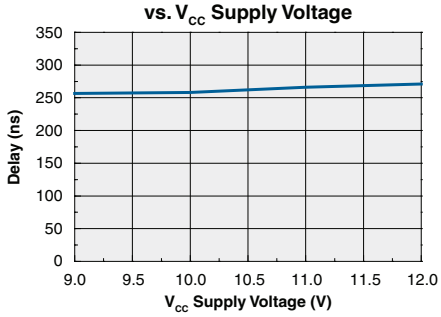
Start-Up Blanking Delay vs. Input Voltage



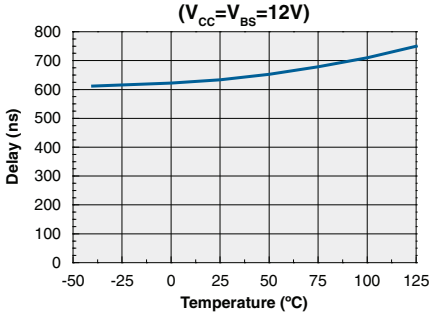
CS Shutdown Propagation Delay vs. Input Voltage



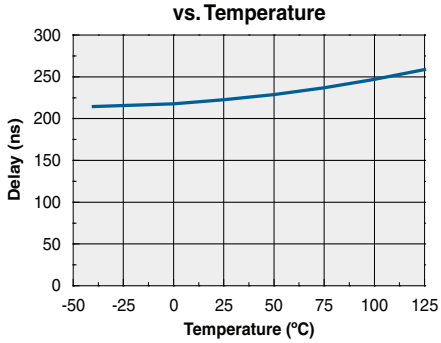
CS to FLT Propagation Delay vs. V_{CC} Supply Voltage



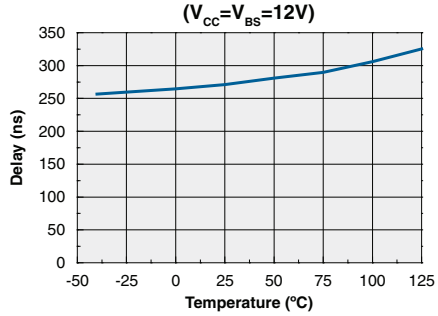
Start-Up Blanking Delay vs. Temperature (V_{CC}=V_{BS}=12V)



CS Shutdown Propogation Delay vs. Temperature



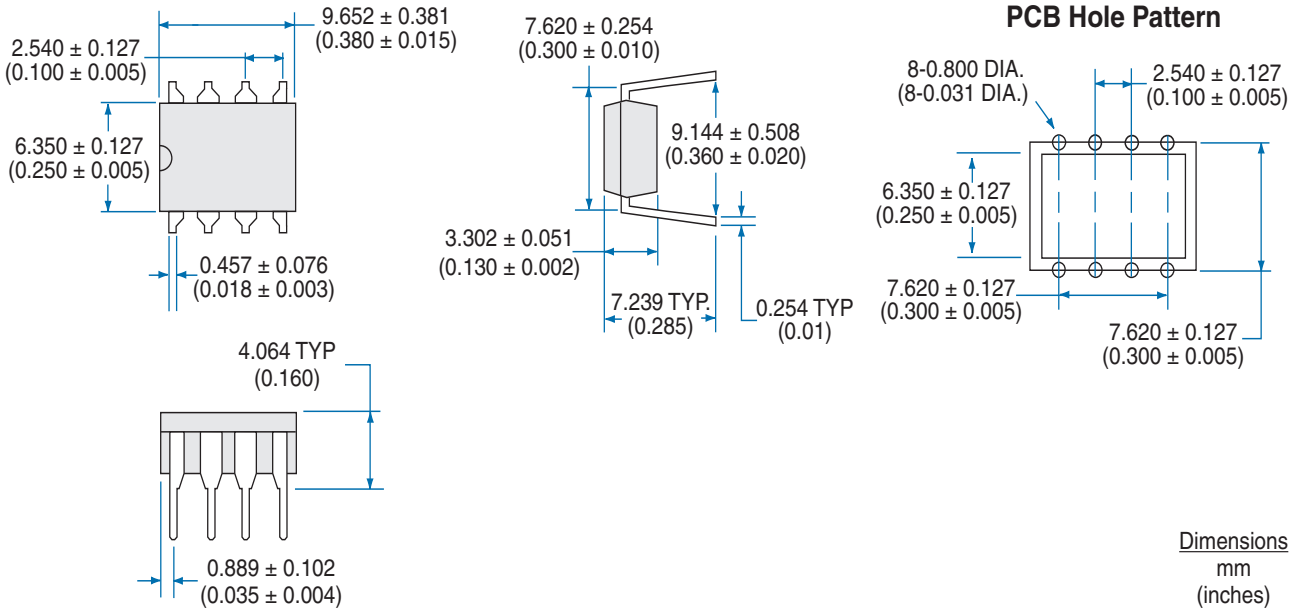
CS to FLT Propagation Delay vs. Temperature (V_{CC}=V_{BS}=12V)



3 Manufacturing Information

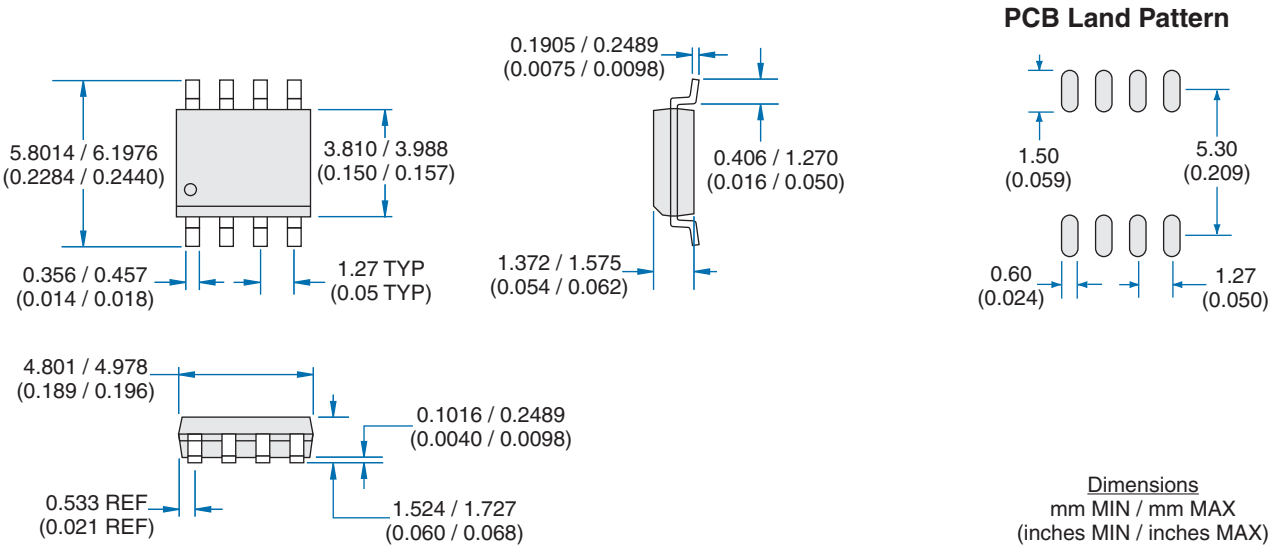
3.1 Mechanical Dimensions

3.1.1 8-Pin DIP Through-Hole Package



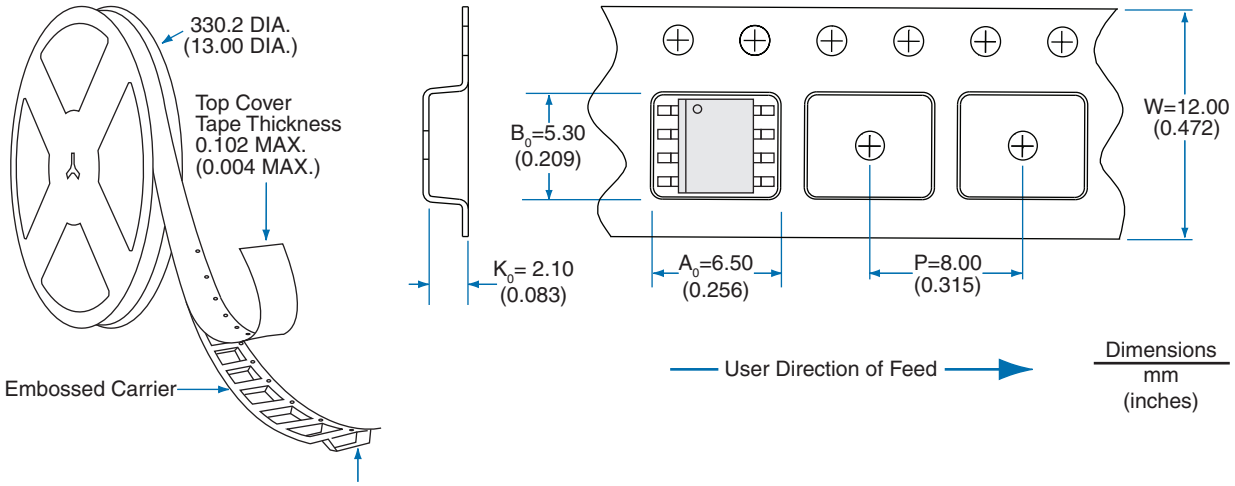
Dimensions
mm
(inches)

3.1.2 8-Pin SOIC Package



Dimensions
mm MIN / mm MAX
(inches MIN / inches MAX)

3.1.3 Tape & Reel Packaging for 8-Pin SOIC Package



NOTE: Tape dimensions not shown comply with JEDEC Standard EIA-481-2

3.2 Soldering

For proper assembly, the component must be processed in accordance with the current revision of IPC/JEDEC standard J-STD-020. Failure to follow the recommended guidelines may cause permanent damage to the device resulting in impaired performance and/or a reduced lifetime expectancy.

3.3 Washing

Clare does not recommend ultrasonic cleaning or the use of chlorinated hydrocarbons.

For additional information please visit our website at: www.clare.com

Specification: DS-IX2127-R01

2/22/2010